Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/051,367	CRAPO ET AL.	
Examiner	Art Unit	
Shengjun Wang	1617	

SEARCHED					
Class	Subclass	Date	Examiner		
514	183-185	10/26/2006	sw		
_					
		<b>—</b>			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	.1				

CH STRATEGY	()
DATE	EXMR
	<del>† ,</del>
	1
	†
	DATE